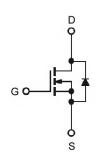


N-Channel 100-V (D-S) MOSFET

Description

The device is using trench DMOS technology. This advanced technology has been especially tailored to minimize R_{DS(ON)}, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

Graphic Symbol



Package Dimension

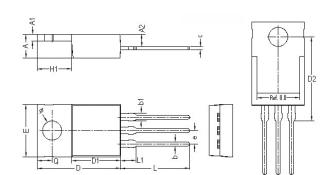
Features

- $R_{DS(ON)} = 5.5 \text{m}\Omega @ V_{GS} = 10V$
- Fast switching
- Improve dv/dt Capability
- 100% EAS Guaranteed
- Green Device Available

Typical Applications

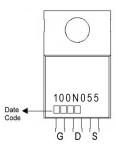
- Motor Driver
- Load Switch
- Synchronous Rectifier
- **BMS** Applications

Package type: TO-220



REF.	Millimeter		REF.	Millimeter		
	Min.	Max.	NEF.	Min.	Max.	
Α	4.30	4.70	D2	15.70	17.00	
A1	1.20	1.40	Е	9.70	10.36	
A2	2.30	2.79	е	2.54 BSC		
b	0.70	0.90	H1	6.10	6.70	
b1	1.20	1.75	L	12.80	13.90	
С	0.34	0.60	L1	ı	4.00	
D	14.70	16.10	Q	2.60	3.00	
D1	8.60	9.30	Ø	3.55	3.95	

Marking



Packing & Order Information

2,000/Box



RoHS Compliant



N-Channel 100-V (D-S) MOSFET

MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings					
Symbol	Parameter	Value	Units		
V _{DS}	Drain-Source Voltage	100	V		
V _G s	Gate-Source Voltage	±20	V		
I _D	Continuous Drain Current¹ (Tc =25°C)	120	Α		
טו	Continuous Drain Current¹ (Tc=100°C)	100	Α		
I _{DM}	Pulsed Drain Current ^{1,2}	480	Α		
I _{AS}	Single Pulse Avalanche Current, L =0.5mH³	53	Α		
Eas	Single Pulse Avalanche Energy, L =0.5mH³	702	mJ		
	Power Dissipation ⁴ (T _C =25°C)	250	W		
P_D	Power Dissipation ⁴ (T _A =25°C)	2	W		
TJ/TSTG	Operating Junction and Storage Temperature	-50 to +150	°C		

Thermal Resistance Ratings					
Symbol	Parameter	Maximum	Units		
$R_{\theta JA}$	Maximum Junction-to-Ambient ¹	62.5	°C/W		
R ₀ JC	Maximum Junction-to-Case ¹	0.5	°C/W		

Electrical Characteristics (T _J =25°C unless otherwise specified)						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
$V_{\text{GS (th)}}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	2	3	4	V
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	100	-	-	V
g fs	Forward Transconductance	V _{DS} =5V, I _D =30A	-	50	_	S
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =100V, V _{GS} =0V, T _J =25°C V _{DS} =100V, V _{GS} =0V, T _J =125°C	-	-	1 10	μA
R _{DS (on)}	Static Drain-Source On-Resistance ²	V _{GS} =10V, I _D =30A	-	4.5	5.5	mΩ
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V, L =0.5mH, I _{AS} =20A	100	-	-	mJ
V _{SD}	Diode Forward Voltage ²	I _S =50A, V _{GS} =0V, T _J =25°C	-	-	1.3	V
Is	Continuous Source Current ^{1,6}	V V 0V 5	-	-	120	
I _{SM}	Pulsed Source Current ^{2,6}	V _G =V _D =0V, Force Current	-	-	240	Α



N-Channel 100-V (D-S) MOSFET

Dynamic						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge ²	V _{DS} =50V		72		
Qgs	Gate-Source Charge	I _D =20A		28		nC
Qgd	Gate-Drain Charge	V _{GS} =10V		15		
td(on)	Turn-On Delay Time ²	V _{DD} =50V		35		
tr	Rise Time	I _D =20A		18		
td(off)	Turn-Off Delay Time	V _{GS} =10V		45		ns
tf	Fall Time	$R_G = 3.0\Omega$		55		
Ciss	Input Capacitance	V _{DS} =50V		4725		
Coss	Output Capacitance	V _{GS} =0V		609		pF
C _{RSS}	Reverse Transfer Capacitance	f =1.0MHz		14		
Rg	Gate Resistance	V _{GS} =V _{DS} =0V, f =1.0MHz		1		Ω
trr	Reverse Recovery Time	I- 004 II/II 4004/ T' 0500		70		nS
Qrr	Reverse Recovery Charge	IF=30A, dI/dt=100A/μs, Tj=25°C		170		nC

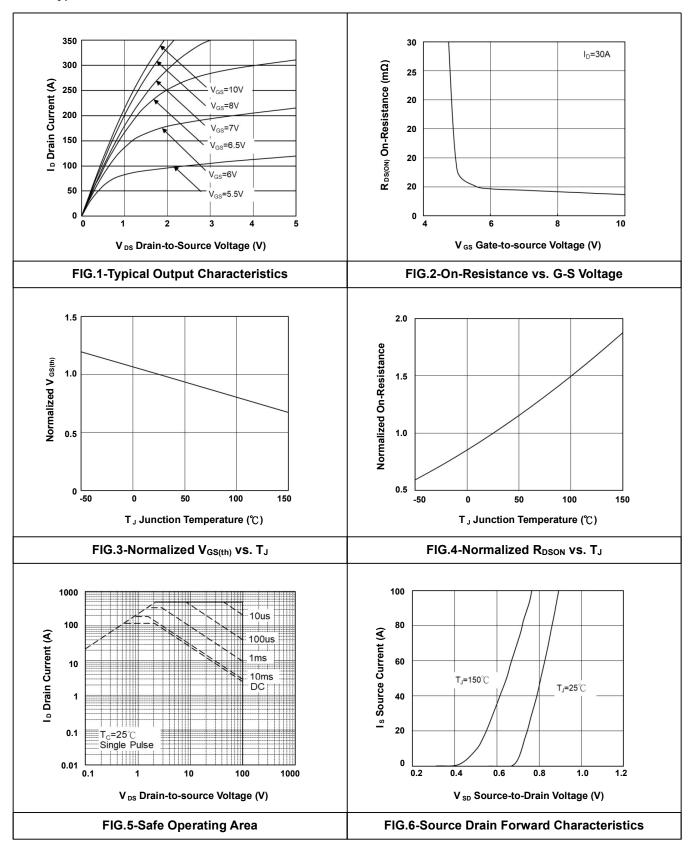
Notes

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
- 3. The EAS data shows maximum rating. The test condition is V_{DD} =25V, V_{GS} =10V, L=0.5mH, I_{AS} =53A.
- 4. The power dissipation is limited by 150° C junction temperature.
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.



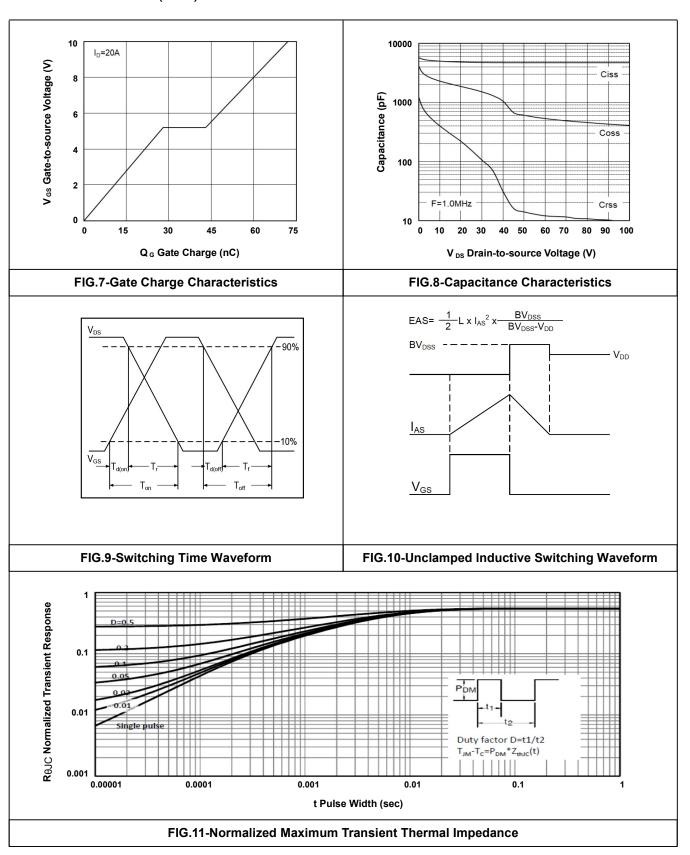
N-Channel 100-V (D-S) MOSFET

Typical Electrical Characteristics





N-Channel 100-V (D-S) MOSFET





N-Channel 100-V (D-S) MOSFET

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